Power MOSFET

40 V, 1.7 m Ω , 185 A, Single N-Channel

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS5C430NWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	40	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain	Steady State	T _C = 25°C	I _D	185	Α
Current R _{θJC} (Notes 1, 3)		T _C = 100°C		131	
Power Dissipation		T _C = 25°C	P_{D}	106	W
R _{θJC} (Note 1)		T _C = 100°C		53	
Continuous Drain	Steady State	T _A = 25°C	I _D	35	Α
Current R _{0JA} (Notes 1, 2, 3)		T _A = 100°C		25	
Power Dissipation		T _A = 25°C	P _D	3.8	W
R _{θJA} (Notes 1 & 2)		T _A = 100°C		1.9	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	900	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to + 175	°C
Source Current (Body Diode)			I _S	102	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 15 A)			E _{AS}	338	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	1.4	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	40	

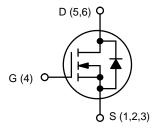
- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Surface–mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
 Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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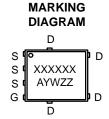
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	1.7 mΩ @ 10 V	185 A



N-CHANNEL MOSFET



ZZ



XXXXXX = 5C430N

(NVMFS5C430N) or

430NWF

(NVMFS5C430NWF)

Α = Assembly Location

= Year W = Work Week

= Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

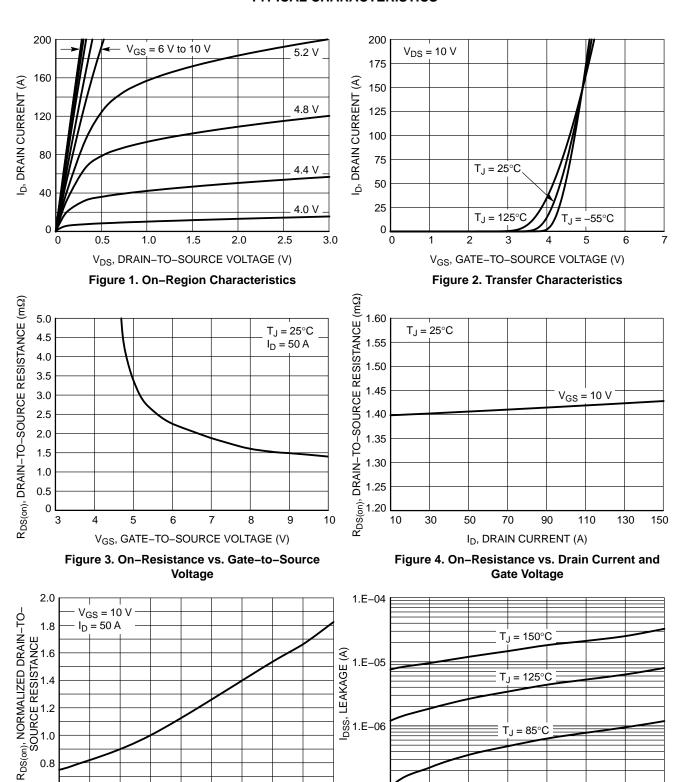
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS				•		•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				12.8		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$, $T_{J} = 25 °C$				10	
		$V_{DS} = 40 \text{ V}$	T _J = 125°C			100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$		2.5		3.5	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-8.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 50 A		1.4	1.7	mΩ
Forward Transconductance	9FS	V _{DS} =15 V, I _D	= 50 A		130		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C _{ISS}				3300		
Output Capacitance	C _{OSS}	$V_{GS} = 0 \text{ V, } f = 1 \text{ MHz, } V_{DS} = 25 \text{ V}$ $V_{GS} = 10 \text{ V, } V_{DS} = 20 \text{ V; } I_{D} = 50 \text{ A}$			1600		pF nC
Reverse Transfer Capacitance	C _{RSS}				45		
Total Gate Charge	Q _{G(TOT)}				47		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 20 V; I _D = 50 A			10		
Gate-to-Source Charge	Q _{GS}				16		
Gate-to-Drain Charge	Q_{GD}				7		
Plateau Voltage	V_{GP}				4.7		V
SWITCHING CHARACTERISTICS (Note 5	5)						
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 10 \text{ V}, V_{DS} = 20 \text{ V},$ $I_{D} = 50 \text{ A}, R_{G} = 2.5 \Omega$			13		- ns
Rise Time	t _r				48		
Turn-Off Delay Time	t _{d(OFF)}				29		
Fall Time	t _f				8		
DRAIN-SOURCE DIODE CHARACTERIS	TICS			•		•	•
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.83	1.2	\/
.63 _ 5	$I_S = 50 \text{ A}$	T _J = 125°C		0.7		V	
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 50 \text{ A}$			57		ns
Charge Time	ta				30		
Discharge Time	t _b				27		
Reverse Recovery Charge	Q _{RR}				68		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



-25 125 150 -50 25 50 75 100 TJ, JUNCTION TEMPERATURE (°C)

Figure 5. On-Resistance Variation with

Temperature

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V) Figure 6. Drain-to-Source Leakage Current vs. Voltage

25

30

35

40

20

 $T_J = 125^{\circ}C$

 $T_J = 85^{\circ}C$

175

1.E-07

10

15

TYPICAL CHARACTERISTICS

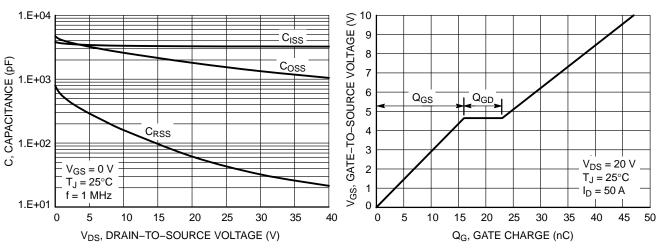


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source Voltage vs. Charge

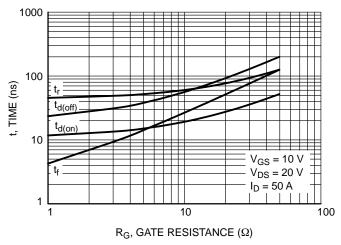


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

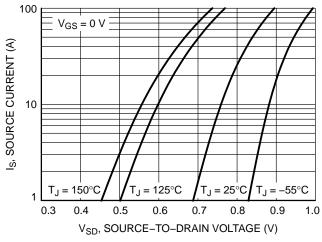


Figure 10. Diode Forward Voltage vs. Current

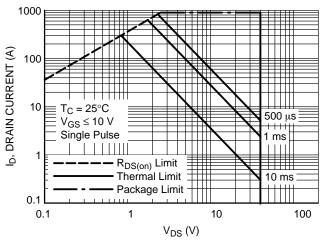


Figure 11. Safe Operating Area

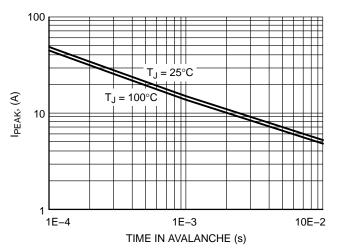


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

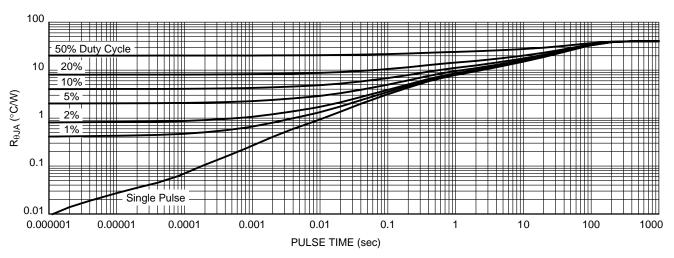


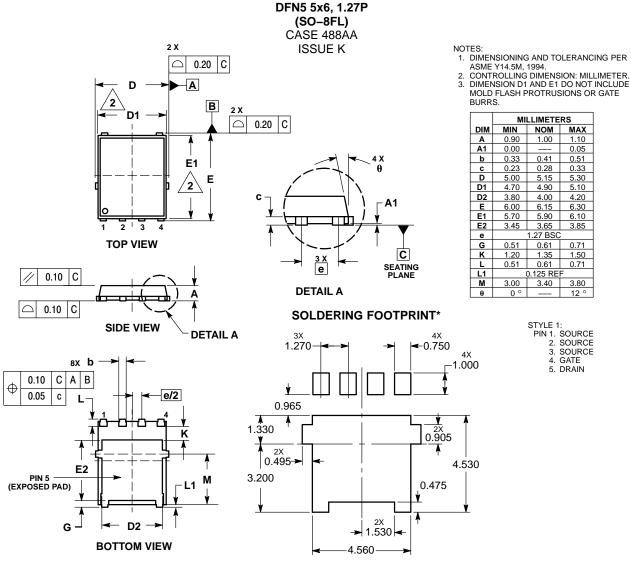
Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMFS5C430NT1G	5C430N	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5C430NWFT1G	430NWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel
NVMFS5C430NT3G	5C430N	DFN5 (Pb-Free)	5000 / Tape & Reel
NVMFS5C430NWFT3G	430NWF	DFN5 (Pb-Free, Wettable Flanks)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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